

# SN74SSTU32864

## 25-BIT CONFIGURABLE REGISTERED BUFFER WITH SSTL\_18 INPUTS AND OUTPUTS

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- Member of the Texas Instruments Widebus+™ Family
- Pinout Optimizes DDR-II DIMM PCB Layout
- Configurable as 25-Bit 1:1 or 14-Bit 1:2 Registered Buffer
- Chip-Select Inputs Gate the Data Outputs from Changing State and Minimizes System Power Consumption
- Output Edge-Control Circuitry Minimizes Switching Noise in an Unterminated Line
- Supports SSTL\_18 Data Inputs
- Differential Clock (CLK and  $\overline{\text{CLK}}$ ) Inputs
- Supports LVCMOS Switching Levels on the Control and  $\overline{\text{RESET}}$  Inputs
- $\overline{\text{RESET}}$  Input Disables Differential Input Receivers, Resets All Registers, and Forces All Outputs Low
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 5000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

### description/ordering information

This 25-bit 1:1 or 14-bit 1:2 configurable registered buffer is designed for 1.7-V to 1.9-V  $V_{CC}$  operation. In the 1:1 pinout configuration, only one device per DIMM is required to drive nine SDRAM loads. In the 1:2 pinout configuration, two devices per DIMM are required to drive 18 SDRAM loads.

All inputs are SSTL\_18, except the LVCMOS reset ( $\overline{\text{RESET}}$ ) and LVCMOS control (Cn) inputs. All outputs are edge-controlled circuits optimized for unterminated DIMM loads and meet SSTL\_18 specifications.

The SN74SSTU32864 operates from a differential clock (CLK and  $\overline{\text{CLK}}$ ). Data are registered at the crossing of CLK going high and  $\overline{\text{CLK}}$  going low.

The C0 input controls the pinout configuration of the 1:2 pinout from register-A configuration (when low) to register-B configuration (when high). The C1 input controls the pinout configuration from 25-bit 1:1 (when low) to 14-bit 1:2 (when high). C0 and C1 should not be switched during normal operation. They should be hard-wired to a valid low or high level to configure the register in the desired mode. In the 25-bit 1:1 pinout configuration, the A6, D6, and H6 terminals are driven low and should not be used.

The device supports low-power standby operation. When  $\overline{\text{RESET}}$  is low, the differential input receivers are disabled, and undriven (floating) data, clock, and reference voltage ( $V_{REF}$ ) inputs are allowed. In addition, when  $\overline{\text{RESET}}$  is low, all registers are reset and all outputs are forced low. The LVCMOS  $\overline{\text{RESET}}$  and Cn inputs always must be held at a valid logic high or low level.

The two  $V_{REF}$  pins (A3 and T3), are connected together internally by approximately 150  $\Omega$ . However, it is necessary to connect only one of the two  $V_{REF}$  pins to the external  $V_{REF}$  power supply. An unused  $V_{REF}$  pin should be terminated with a  $V_{REF}$  coupling capacitor.

### ORDERING INFORMATION

| TA          | PACKAGE†    |               | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|-------------|-------------|---------------|-----------------------|------------------|
| 0°C to 70°C | LFBGA – GKE | Tape and reel | SN74SSTU32864GKER     | SU864            |

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at [www.ti.com/sc/package](http://www.ti.com/sc/package).



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## 25-BIT CONFIGURABLE REGISTERED BUFFER

### WITH SSTL\_18 INPUTS AND OUTPUTS

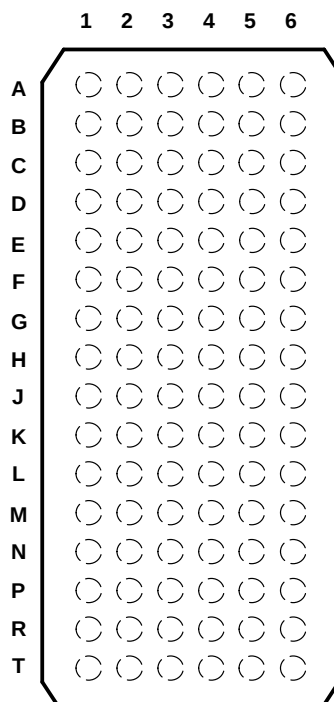
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#### description/ordering information (continued)

The device also supports low-power active operation by monitoring both system chip select ( $\overline{DCS}$  and  $\overline{CSR}$ ) inputs and will gate the Qn outputs from changing states when both  $\overline{DCS}$  and  $\overline{CSR}$  inputs are high. If either  $\overline{DCS}$  or  $\overline{CSR}$  input is low, the Qn outputs function normally. The  $\overline{RESET}$  input has priority over the  $\overline{DCS}$  and  $\overline{CSR}$  control and forces the output low. If the  $\overline{DCS}$  control functionality is not desired, the  $\overline{CSR}$  input can be hard-wired to ground, in which case, the setup-time requirement for  $\overline{DCS}$  is the same as for the other D data inputs.

To ensure defined outputs from the register before a stable clock has been supplied,  $\overline{RESET}$  must be held in the low state during power up.

GKE PACKAGE  
(TOP VIEW)



terminal assignments for 1:1 register (C0 = 0, C1 = 0)

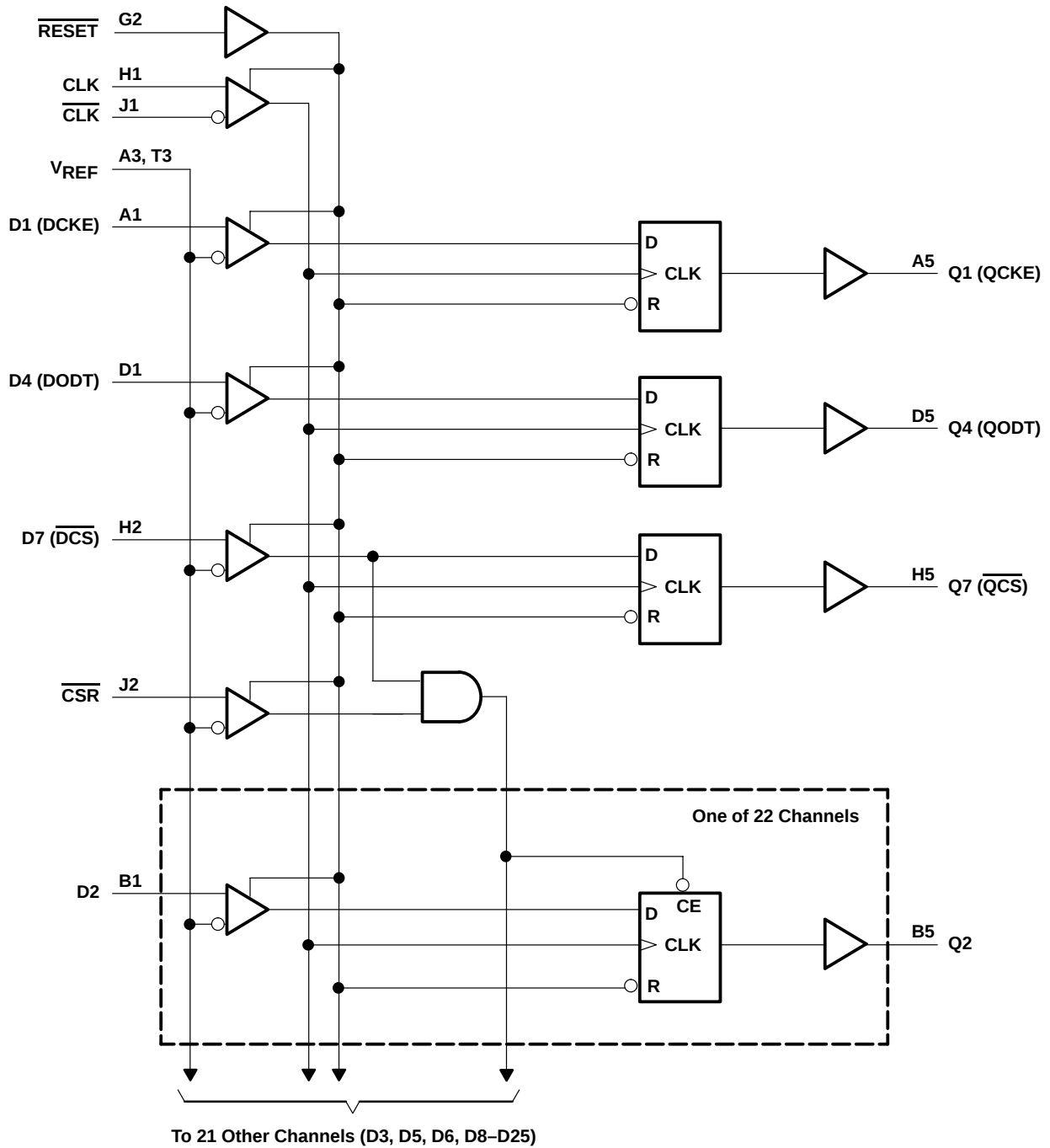
|   | 1                | 2                       | 3    | 4   | 5                       | 6   |
|---|------------------|-------------------------|------|-----|-------------------------|-----|
| A | D1 (DCKE)        | NC                      | VREF | VCC | Q1 (QCKE)               | DNU |
| B | D2               | D15                     | GND  | GND | Q2                      | Q15 |
| C | D3               | D16                     | VCC  | VCC | Q3                      | Q16 |
| D | D4 (DODT)        | NC                      | GND  | GND | Q4 (QODT)               | DNU |
| E | D5               | D17                     | VCC  | VCC | Q5                      | Q17 |
| F | D6               | D18                     | GND  | GND | Q6                      | Q18 |
| G | NC               | $\overline{RESET}$      | VCC  | VCC | C1                      | C0  |
| H | CLK              | D7 ( $\overline{DCS}$ ) | GND  | GND | Q7 ( $\overline{QCS}$ ) | DNU |
| J | $\overline{CLK}$ | $\overline{CSR}$        | VCC  | VCC | NC                      | NC  |
| K | D8               | D19                     | GND  | GND | Q8                      | Q19 |
| L | D9               | D20                     | VCC  | VCC | Q9                      | Q20 |
| M | D10              | D21                     | GND  | GND | Q10                     | Q21 |
| N | D11              | D22                     | VCC  | VCC | Q11                     | Q22 |
| P | D12              | D23                     | GND  | GND | Q12                     | Q23 |
| R | D13              | D24                     | VCC  | VCC | Q13                     | Q24 |
| T | D14              | D25                     | VREF | VCC | Q14                     | Q25 |

Each pin name in parentheses indicates the DDR-II DIMM signal name.

NC – No internal connection

DNU – Do not use

logic diagram for 1:1 register configuration (positive logic)



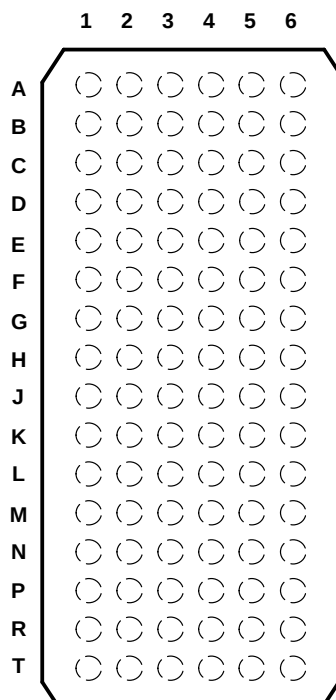
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## 25-BIT CONFIGURABLE REGISTERED BUFFER

### WITH SSTL\_18 INPUTS AND OUTPUTS

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#### GKE PACKAGE (TOP VIEW)



#### terminal assignments for 1:2 register A (C0 = 0, C1 = 1)

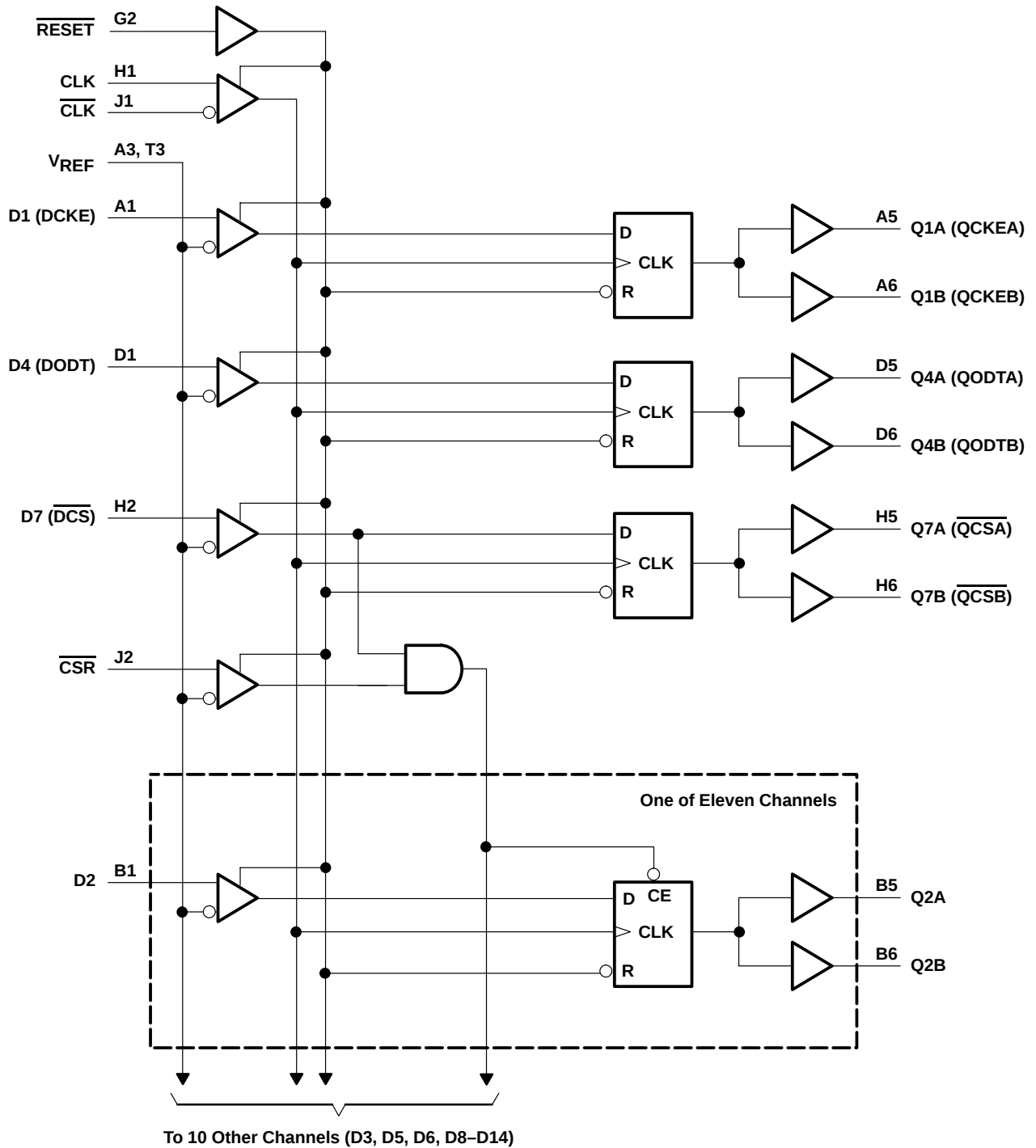
|   | 1         | 2        | 3    | 4   | 5           | 6           |
|---|-----------|----------|------|-----|-------------|-------------|
| A | D1 (DCKE) | NC       | VREF | VCC | Q1A (QCKEA) | Q1B (QCKEB) |
| B | D2        | DNU      | GND  | GND | Q2A         | Q2B         |
| C | D3        | DNU      | VCC  | VCC | Q3A         | Q3B         |
| D | D4 (DODT) | NC       | GND  | GND | Q4A (QODTA) | Q4B (QODTB) |
| E | D5        | DNU      | VCC  | VCC | Q5A         | Q5B         |
| F | D6        | DNU      | GND  | GND | Q6A         | Q6B         |
| G | NC        | RESET    | VCC  | VCC | C1          | C0          |
| H | CLK       | D7 (DCS) | GND  | GND | Q7A (QCSA)  | Q7B (QCSB)  |
| J | CLK       | CSR      | VCC  | VCC | NC          | NC          |
| K | D8        | DNU      | GND  | GND | Q8A         | Q8B         |
| L | D9        | DNU      | VCC  | VCC | Q9A         | Q9B         |
| M | D10       | DNU      | GND  | GND | Q10A        | Q10B        |
| N | D11       | DNU      | VCC  | VCC | Q11A        | Q11B        |
| P | D12       | DNU      | GND  | GND | Q12A        | Q12B        |
| R | D13       | DNU      | VCC  | VCC | Q13A        | Q13B        |
| T | D14       | DNU      | VREF | VCC | Q14A        | Q14B        |

Each pin name in parentheses indicates the DDR-II DIMM signal name.

NC – No internal connection

DNU – Do not use

logic diagram 1:2 register-A configuration (positive logic)



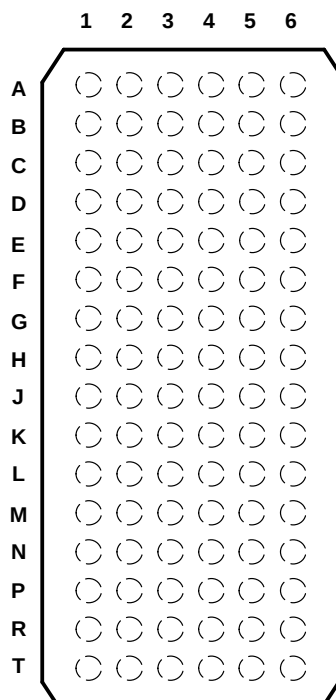
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## 25-BIT CONFIGURABLE REGISTER BUFFER

### WITH SSTL\_18 INPUTS AND OUTPUTS

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#### GKE PACKAGE (TOP VIEW)



#### terminal assignments for 1:2 register B (C0 = 1, C1 = 1)

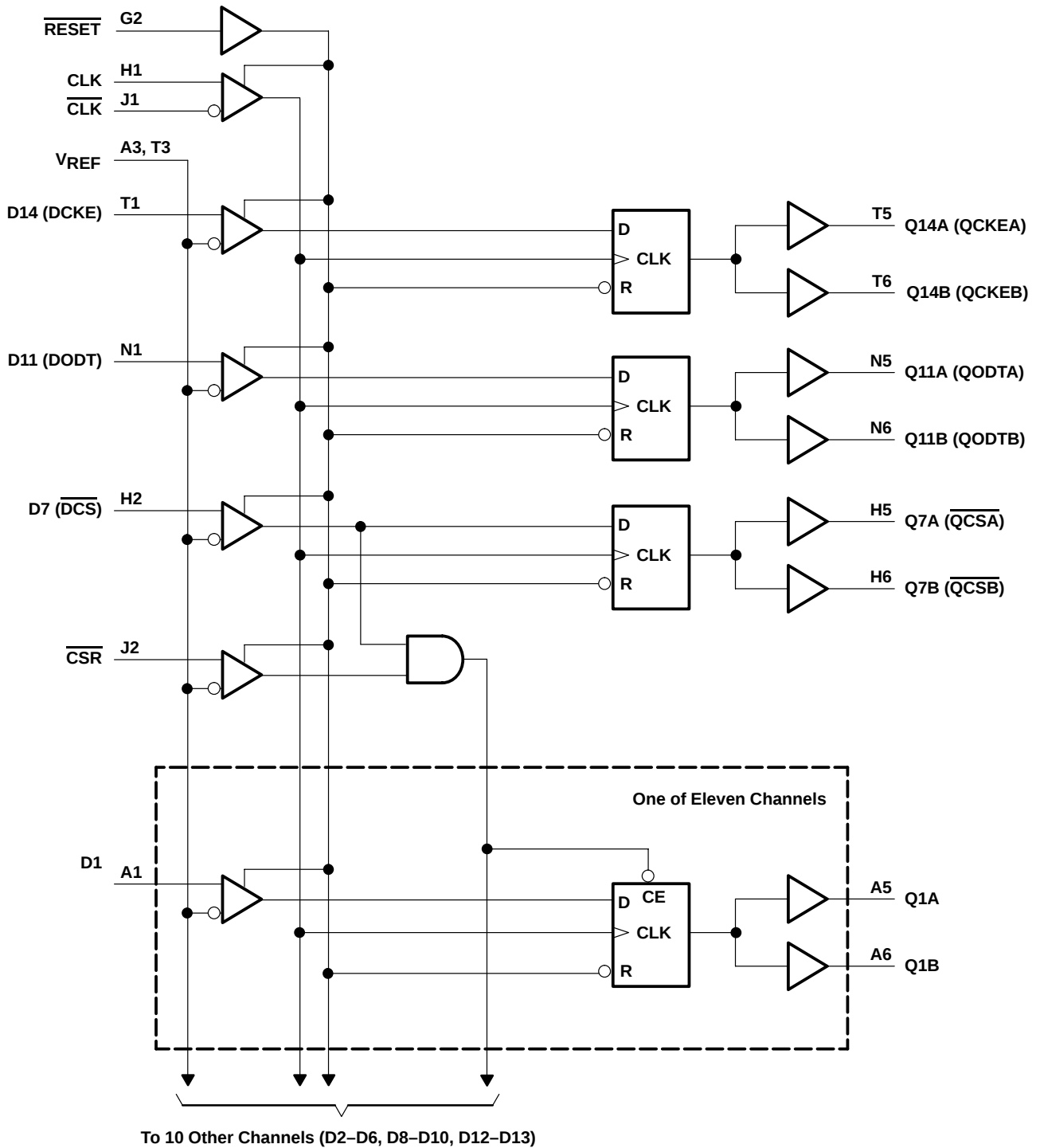
|   | 1             | 2        | 3                | 4               | 5               | 6               |
|---|---------------|----------|------------------|-----------------|-----------------|-----------------|
| A | D1            | NC       | V <sub>REF</sub> | V <sub>CC</sub> | Q1A             | Q1B             |
| B | D2            | DNU      | GND              | GND             | Q2A             | Q2B             |
| C | D3            | DNU      | V <sub>CC</sub>  | V <sub>CC</sub> | Q3A             | Q3B             |
| D | D4            | NC       | GND              | GND             | Q4A             | Q4B             |
| E | D5            | DNU      | V <sub>CC</sub>  | V <sub>CC</sub> | Q5A             | Q5B             |
| F | D6            | DNU      | GND              | GND             | Q6A             | Q6B             |
| G | NC            | RESET    | V <sub>CC</sub>  | V <sub>CC</sub> | C1              | C0              |
| H | CLK           | D7 (DCS) | GND              | GND             | Q7A<br>(QCSA)   | Q7B<br>(QCSB)   |
| J | CLK           | CSR      | V <sub>CC</sub>  | V <sub>CC</sub> | NC              | NC              |
| K | D8            | DNU      | GND              | GND             | Q8A             | Q8B             |
| L | D9            | DNU      | V <sub>CC</sub>  | V <sub>CC</sub> | Q9A             | Q9B             |
| M | D10           | DNU      | GND              | GND             | Q10A            | Q10B            |
| N | D11<br>(DODT) | DNU      | V <sub>CC</sub>  | V <sub>CC</sub> | Q11A<br>(QODTA) | Q11B<br>(QODTB) |
| P | D12           | DNU      | GND              | GND             | Q12A            | Q12B            |
| R | D13           | DNU      | V <sub>CC</sub>  | V <sub>CC</sub> | Q13A            | Q13B            |
| T | D14<br>(DCKE) | DNU      | V <sub>REF</sub> | V <sub>CC</sub> | Q14A<br>(QCKEA) | Q14B<br>(QCKEB) |

Each pin name in parentheses indicates the DDR-II DIMM signal name.

NC – No internal connection

DNU – Do not use

logic diagram 1:2 register-B configuration (positive logic)



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## 25-BIT CONFIGURABLE REGISTERED BUFFER

### WITH SSTL\_18 INPUTS AND OUTPUTS

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#### TERMINAL FUNCTIONS

| TERMINAL NAME                                  | DESCRIPTION                                                                                                                | ELECTRICAL CHARACTERISTICS |
|------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------|----------------------------|
| GND                                            | Ground                                                                                                                     | Ground input               |
| VCC                                            | Power-supply voltage                                                                                                       | 1.8 V nominal              |
| VREF                                           | Input reference voltage                                                                                                    | 0.9 V nominal              |
| CLK                                            | Positive master clock input                                                                                                | Differential input         |
| $\overline{\text{CLK}}$                        | Negative master clock input                                                                                                | Differential input         |
| C0, C1                                         | Configuration control inputs – Register A, Register B, 1:1, 1:2 select                                                     | LVC MOS inputs             |
| $\overline{\text{RESET}}$                      | Asynchronous reset input – resets registers and disables VREF data and clock differential-input receivers                  | LVC MOS input              |
| D1–D25                                         | Data inputs – clocked in on the crossing of the rising edge of CLK and the falling edge of CLK                             | SSTL_18 inputs             |
| $\overline{\text{CSR}}, \overline{\text{DCS}}$ | Chip select inputs – disables D1–D25 <sup>†</sup> outputs switching when both inputs are high                              | SSTL_18 inputs             |
| DODT                                           | The outputs of this register bit will not be suspended by the $\overline{\text{DCS}}$ and $\overline{\text{CSR}}$ control. | SSTL_18 input              |
| DCKE                                           | The outputs of this register bit will not be suspended by the $\overline{\text{DCS}}$ and $\overline{\text{CSR}}$ control. | SSTL_18 input              |
| Q1–Q25 <sup>‡</sup>                            | Data outputs that are suspended by the $\overline{\text{DCS}}$ and $\overline{\text{CSR}}$ control                         | 1.8 V CMOS outputs         |
| $\overline{\text{QCS}}$                        | Data output that will not be suspended by the $\overline{\text{DCS}}$ and $\overline{\text{CSR}}$ control                  | 1.8 V CMOS output          |
| QODT                                           | Data output that will not be suspended by the $\overline{\text{DCS}}$ and $\overline{\text{CSR}}$ control                  | 1.8 V CMOS output          |
| QCKE                                           | Data output that will not be suspended by the $\overline{\text{DCS}}$ and $\overline{\text{CSR}}$ control                  | 1.8 V CMOS output          |
| NC                                             | No internal connection                                                                                                     |                            |
| DNU                                            | Do not use – inputs are in standby-equivalent mode, and outputs are driven low.                                            |                            |

<sup>†</sup> Data inputs = D2, D3, D5, D6, D8–D25 when C0 = 0 and C1 = 0

Data inputs = D2, D3, D5, D6, D8–D14 when C0 = 0 and C1 = 1

Data inputs = D1–D6, D8–D10, D12, D13 when C0 = 1 and C1 = 1.

<sup>‡</sup> Data outputs = Q2, Q3, Q5, Q6, Q8–Q25 when C0 = 0 and C1 = 0

Data outputs = Q2, Q3, Q5, Q6, Q8–Q14 when C0 = 0 and C1 = 1

Data outputs = Q1–Q6, Q8–Q10, Q12, Q13 when C0 = 1 and C1 = 1.



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FUNCTION TABLES

| INPUTS |               |               |               |               |               | OUTPUT<br>Qn   |
|--------|---------------|---------------|---------------|---------------|---------------|----------------|
| RESET  | DCS           | CSR           | CLK           | CLK           | Dn            |                |
| H      | L             | X             | ↑             | ↓             | L             | L              |
| H      | L             | X             | ↑             | ↓             | H             | H              |
| H      | X             | L             | ↑             | ↓             | L             | L              |
| H      | X             | L             | ↑             | ↓             | H             | H              |
| H      | H             | H             | ↑             | ↓             | X             | Q <sub>0</sub> |
| H      | X             | X             | L or H        | L or H        | X             | Q <sub>0</sub> |
| L      | X or floating | X or floating | X or floating | X or floating | X or floating | L              |

| INPUTS |               |               |                       | OUTPUTS        |
|--------|---------------|---------------|-----------------------|----------------|
| RESET  | CLK           | CLK           | DCKE,<br>DCS,<br>DODT |                |
| H      | ↑             | ↓             | H                     | H              |
| H      | ↑             | ↓             | L                     | L              |
| H      | L or H        | L or H        | X                     | Q <sub>0</sub> |
| L      | X or floating | X or floating | X or floating         | L              |

**absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>**

|                                                                                                 |                                   |
|-------------------------------------------------------------------------------------------------|-----------------------------------|
| Supply voltage range, V <sub>CC</sub>                                                           | –0.5 V to 2.5 V                   |
| Input voltage range, V <sub>I</sub> (see Notes 1 and 2)                                         | –0.5 V to 2.5 V                   |
| Output voltage range, V <sub>O</sub> (see Notes 1 and 2)                                        | –0.5 V to V <sub>CC</sub> + 0.5 V |
| Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CC</sub> )  | ±50 mA                            |
| Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> ) | ±50 mA                            |
| Continuous output current, I <sub>O</sub> (V <sub>O</sub> = 0 to V <sub>CC</sub> )              | ±50 mA                            |
| Continuous current through each V <sub>CC</sub> or GND                                          | ±100 mA                           |
| Package thermal impedance, θ <sub>JA</sub> (see Note 3)                                         | 36°C/W                            |
| Storage temperature range, T <sub>stg</sub>                                                     | –65°C to 150°C                    |

<sup>†</sup> Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.  
2. This value is limited to 2.5 V maximum.  
3. The package thermal impedance is calculated in accordance with JESD 51-7.

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## 25-BIT CONFIGURABLE REGISTERED BUFFER

### WITH SSTL\_18 INPUTS AND OUTPUTS

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#### recommended operating conditions (see Note 4)

|                    |                                 |                               | MIN                      | NOM                 | MAX                  | UNIT |
|--------------------|---------------------------------|-------------------------------|--------------------------|---------------------|----------------------|------|
| V <sub>CC</sub>    | Supply voltage                  |                               | 1.7                      |                     | 1.9                  | V    |
| V <sub>REF</sub>   | Reference voltage               |                               | $0.49 \times V_{CC}$     | $0.5 \times V_{CC}$ | $0.51 \times V_{CC}$ | V    |
| V <sub>I</sub>     | Input voltage                   |                               | 0                        |                     | V <sub>CC</sub>      | V    |
| V <sub>IH</sub>    | AC high-level input voltage     | Data inputs, $\overline{CSR}$ | V <sub>REF</sub> +250 mV |                     |                      | V    |
| V <sub>IL</sub>    | AC low-level input voltage      | Data inputs, $\overline{CSR}$ | V <sub>REF</sub> -250 mV |                     |                      | V    |
| V <sub>IH</sub>    | DC high-level input voltage     | Data inputs, $\overline{CSR}$ | V <sub>REF</sub> +125 mV |                     |                      | V    |
| V <sub>IL</sub>    | DC low-level input voltage      | Data inputs, $\overline{CSR}$ | V <sub>REF</sub> -125 mV |                     |                      | V    |
| V <sub>IH</sub>    | High-level input voltage        | RESET, Cn                     | $0.65 \times V_{CC}$     |                     |                      | V    |
| V <sub>IL</sub>    | Low-level input voltage         | RESET, Cn                     | $0.35 \times V_{CC}$     |                     |                      | V    |
| V <sub>ICR</sub>   | Common-mode input voltage range | CLK, $\overline{CLK}$         | 0.675                    |                     | 1.125                | V    |
| V <sub>I(PP)</sub> | Peak-to-peak input voltage      | CLK, $\overline{CLK}$         | 600                      |                     |                      | mV   |
| I <sub>OH</sub>    | High-level output current       |                               |                          |                     | -8                   | mA   |
| I <sub>OL</sub>    | Low-level output current        |                               |                          |                     | 8                    |      |
| T <sub>A</sub>     | Operating free-air temperature  |                               | 0                        |                     | 70                   | °C   |

NOTE 4: The RESET and Cn inputs of the device must be held at valid logic voltage levels (not floating) to ensure proper device operation. The differential inputs must not be floating unless RESET is low. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



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**25-BIT CONFIGURABLE REGISTERED BUFFER**  
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**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

| PARAMETER          |                                                               | TEST CONDITIONS                                                                                                                                                                                     |  | V <sub>CC</sub> | MIN                  | TYP <sup>†</sup> | MAX | UNIT                 |
|--------------------|---------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|-----------------|----------------------|------------------|-----|----------------------|
| V <sub>OH</sub>    |                                                               | I <sub>OH</sub> = −100 μA                                                                                                                                                                           |  | 1.7 V to 1.9 V  | V <sub>CC</sub> −0.2 |                  |     | V                    |
|                    |                                                               | I <sub>OH</sub> = −6 mA                                                                                                                                                                             |  | 1.7 V           | 1.2                  |                  |     |                      |
| V <sub>OL</sub>    |                                                               | I <sub>OL</sub> = 100 μA                                                                                                                                                                            |  | 1.7 V to 1.9 V  | 0.2                  |                  |     | V                    |
|                    |                                                               | I <sub>OL</sub> = 6 mA                                                                                                                                                                              |  | 1.7 V           | 0.5                  |                  |     |                      |
| I <sub>I</sub>     | All inputs <sup>‡</sup>                                       | V <sub>I</sub> = V <sub>CC</sub> or GND                                                                                                                                                             |  | 1.9 V           | ±5                   |                  |     | μA                   |
| I <sub>CC</sub>    | Static standby                                                | RESET = GND                                                                                                                                                                                         |  | 1.9 V           | 100                  |                  |     | μA                   |
|                    | Static operating                                              | RESET = V <sub>CC</sub> , V <sub>I</sub> = V <sub>IH</sub> (AC) or V <sub>IL</sub> (AC)                                                                                                             |  |                 | 40                   |                  |     | mA                   |
| I <sub>CCD</sub>   | Dynamic operating – clock only                                | RESET = V <sub>CC</sub> , V <sub>I</sub> = V <sub>IH</sub> (AC) or V <sub>IL</sub> (AC), CLK and CLK switching 50% duty cycle                                                                       |  | 1.8 V           | 28                   |                  |     | μA/MHz               |
|                    | Dynamic operating – per each data input, 1:1 configuration    | RESET = V <sub>CC</sub> , V <sub>I</sub> = V <sub>IH</sub> (AC) or V <sub>IL</sub> (AC), CLK and CLK switching 50% duty cycle, One data input switching at one-half clock frequency, 50% duty cycle |  |                 | 18                   |                  |     | μA/clock MHz/D input |
|                    | Dynamic operating – per each data input, 1:2 configuration    |                                                                                                                                                                                                     |  |                 | 36                   |                  |     |                      |
| I <sub>CCDLP</sub> | Chip-select-enabled low-power active mode – clock only        | RESET = V <sub>CC</sub> , V <sub>I</sub> = V <sub>IH</sub> (AC) or V <sub>IL</sub> (AC), CLK and CLK switching 50% duty cycle                                                                       |  | 1.8 V           | 27                   |                  |     | μA/MHz               |
|                    | Chip-select-enabled low-power active mode – 1:1 configuration | RESET = V <sub>CC</sub> , V <sub>I</sub> = V <sub>IH</sub> (AC) or V <sub>IL</sub> (AC), CLK and CLK switching 50% duty cycle, One data input switching at one-half clock frequency, 50% duty cycle |  |                 | 2                    |                  |     | μA/clock MHz/D input |
|                    | Chip-select-enabled low-power active mode – 1:2 configuration |                                                                                                                                                                                                     |  |                 | 2                    |                  |     |                      |
| C <sub>i</sub>     | Data inputs, CSR                                              | V <sub>I</sub> = V <sub>REF</sub> ± 250 mV                                                                                                                                                          |  | 1.8 V           | 2.5                  | 3                | 3.5 | pF                   |
|                    | CLK, CLK                                                      | V <sub>ICR</sub> = 0.9 V, V <sub>I</sub> (PP) = 600 mV                                                                                                                                              |  |                 | 2                    | 3                |     |                      |
|                    | RESET                                                         | V <sub>I</sub> = V <sub>CC</sub> or GND                                                                                                                                                             |  |                 | 2.5                  |                  |     |                      |

<sup>†</sup> All typical values are at V<sub>CC</sub> = 1.8 V, T<sub>A</sub> = 25°C.

<sup>‡</sup> Each V<sub>REF</sub> pin (A3 or T3) should be tested independently, with the other (untested) pin open.

**timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1 and Note 5)**

|                    |                                                | MIN                                                              | MAX | UNIT |
|--------------------|------------------------------------------------|------------------------------------------------------------------|-----|------|
| f <sub>clock</sub> | Clock frequency                                |                                                                  | 500 | MHz  |
| t <sub>w</sub>     | Pulse duration, CLK, CLK high or low           | 1                                                                |     | ns   |
| t <sub>act</sub>   | Differential inputs active time (see Note 6)   |                                                                  | 10  | ns   |
| t <sub>inact</sub> | Differential inputs inactive time (see Note 7) |                                                                  | 15  | ns   |
| t <sub>su</sub>    | Setup time                                     | DCS before CLK↑, CLK↓, CSR high; CSR before CLK↑, CLK↓, DCS high | 0.7 | ns   |
|                    |                                                | DCS before CLK↑, CLK↓, CSR low                                   | 0.5 |      |
|                    |                                                | DODT, DCKE, and Data before CLK↑, CLK↓                           | 0.5 |      |
| t <sub>h</sub>     | Hold time                                      | DCS, DODT, DCKE, and Data after CLK↑, CLK↓                       | 0.5 | ns   |

NOTES: 5. All input slew rates are 1 V/ns ±20%.

6. V<sub>REF</sub> must be held at a valid input level and data inputs must be held low for a minimum time of t<sub>act</sub> max, after RESET is taken high.

7. V<sub>REF</sub>, data, and clock inputs must be held at valid voltage levels (not floating) for a minimum time of t<sub>inact</sub> max, after RESET is taken low.



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# SN74SSTU32864

## 25-BIT CONFIGURABLE REGISTERED BUFFER

### WITH SSTL\_18 INPUTS AND OUTPUTS

SCES434 – MARCH 2003

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

| PARAMETER             | FROM<br>(INPUT)          | TO<br>(OUTPUT) | $V_{CC} = 1.8\text{ V}$<br>$\pm 0.1\text{ V}$ |     | UNIT |
|-----------------------|--------------------------|----------------|-----------------------------------------------|-----|------|
|                       |                          |                | MIN                                           | MAX |      |
| $f_{max}$             |                          |                | 500                                           |     | MHz  |
| $t_{pdm}^{\dagger}$   | CLK and $\overline{CLK}$ | Q              | 1.4                                           | 2.5 | ns   |
| $t_{pdmss}^{\dagger}$ | CLK and $\overline{CLK}$ | Q              |                                               | 2.7 | ns   |
| $t_{RPHL}^{\dagger}$  | $\overline{RESET}$       | Q              |                                               | 3   | ns   |

<sup>†</sup> Includes 350-ps test-load transmission-line delay

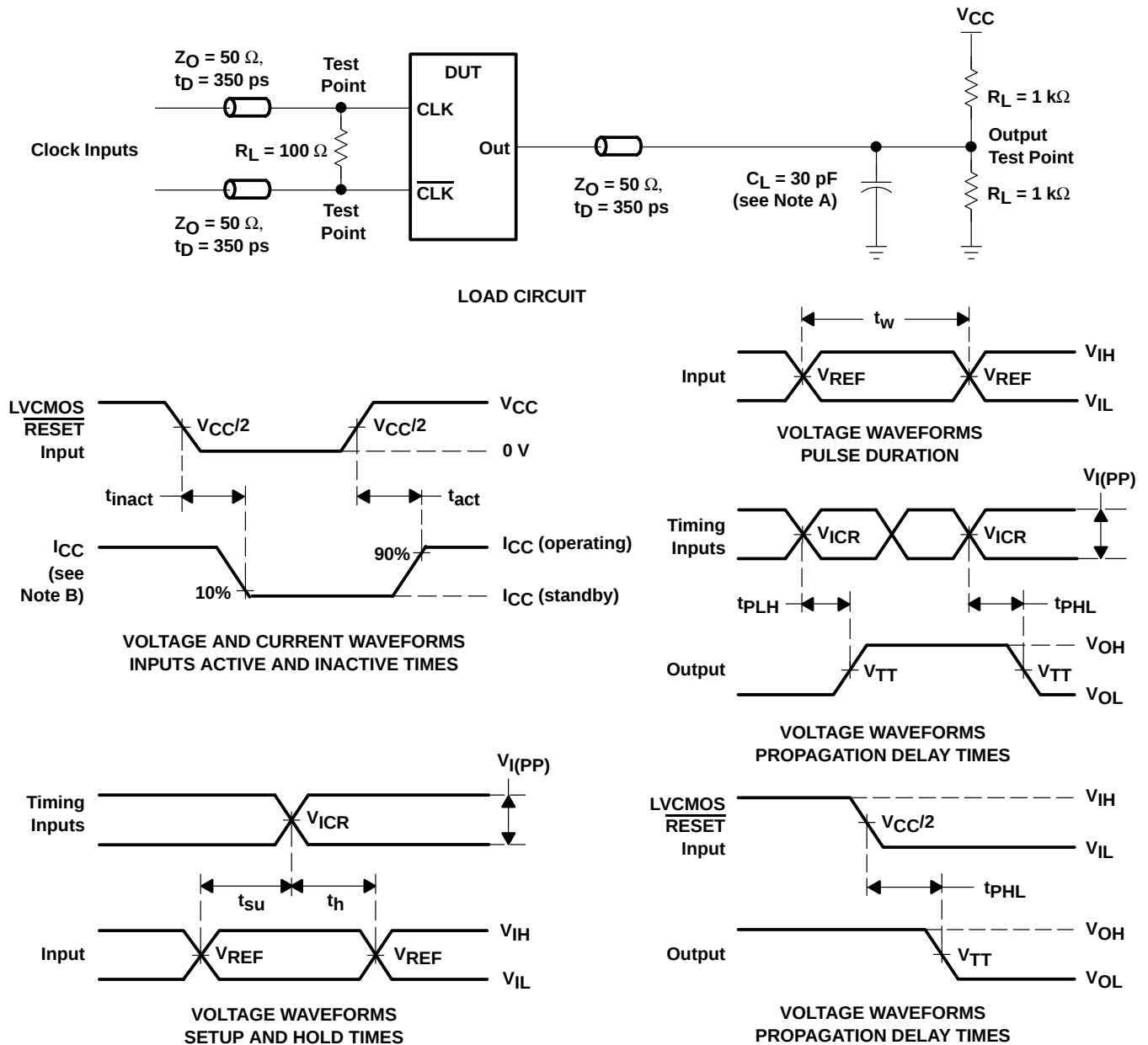
output slew rates over recommended operating free-air temperature range (unless otherwise noted) (see Figure 2)

| PARAMETER             | FROM       | TO         | $V_{CC} = 1.8\text{ V}$<br>$\pm 0.1\text{ V}$ |     | UNIT |
|-----------------------|------------|------------|-----------------------------------------------|-----|------|
|                       |            |            | MIN                                           | MAX |      |
| $dV/dt_r$             | 20%        | 80%        | 1.9                                           | 4.9 | V/ns |
| $dV/dt_f$             | 80%        | 20%        | 1.9                                           | 4.9 | V/ns |
| $dV/dt_{\Delta}^{\S}$ | 20% or 80% | 80% or 20% |                                               | 1   | V/ns |

<sup>\S</sup> Difference between  $dV/dt_r$  (rising edge rate) and  $dV/dt_f$  (falling edge rate)



## PARAMETER MEASUREMENT INFORMATION



- NOTES:
- $C_L$  includes probe and jig capacitance.
  - $I_{CC}$  tested with clock and data inputs held at  $V_{CC}$  or GND, and  $I_O = 0\ \text{mA}$ .
  - All input pulses are supplied by generators having the following characteristics:  $\text{PRR} \leq 10\ \text{MHz}$ ,  $Z_O = 50\ \Omega$ , input slew rate =  $1\ \text{V/ns} \pm 20\%$  (unless otherwise noted).
  - The outputs are measured one at a time with one transition per measurement.
  - $V_{REF} = V_{CC}/2$
  - $V_{IH} = V_{REF} + 250\ \text{mV}$  (ac voltage levels) for differential inputs.  $V_{IH} = V_{CC}$  for LVC MOS input.
  - $V_{IL} = V_{REF} - 250\ \text{mV}$  (ac voltage levels) for differential inputs.  $V_{IL} = \text{GND}$  for LVC MOS input.
  - $V_{I(PP)} = 600\ \text{mV}$
  - $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{PD}$ .

**Figure 1. Load Circuit and Voltage Waveforms**

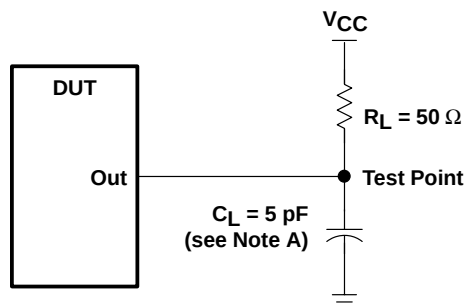
# SN74SSTU32864

## 25-BIT CONFIGURABLE REGISTERED BUFFER

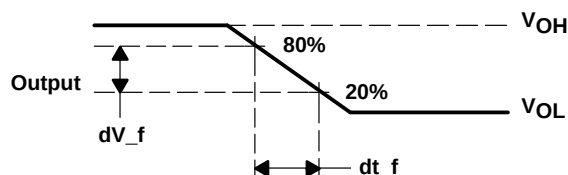
### WITH SSTL\_18 INPUTS AND OUTPUTS

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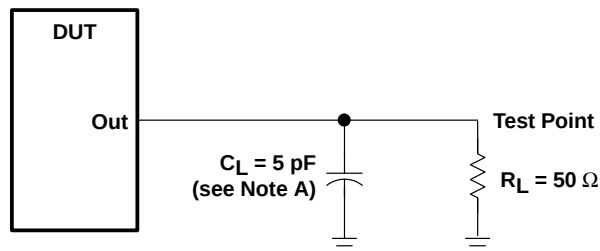
#### PARAMETER MEASUREMENT INFORMATION



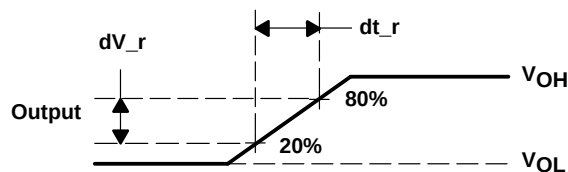
LOAD CIRCUIT  
HIGH-TO-LOW SLEW-RATE MEASUREMENT



VOLTAGE WAVEFORMS  
HIGH-TO-LOW SLEW-RATE MEASUREMENT



LOAD CIRCUIT  
LOW-TO-HIGH SLEW-RATE MEASUREMENT



VOLTAGE WAVEFORMS  
LOW-TO-HIGH SLEW-RATE MEASUREMENT

- NOTES: A.  $C_L$  includes probe and jig capacitance.  
B. All input pulses are supplied by generators having the following characteristics:  
PRR  $\leq 10 \text{ MHz}$ ,  $Z_O = 50 \Omega$ , input slew rate =  $1 \text{ V/ns} \pm 20\%$  (unless otherwise specified).

Figure 2. Output Slew-Rate Measurement Information

## PACKAGING INFORMATION

| Orderable Device  | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|-------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| SN74SSTU32864NMJR | ACTIVE        | NFBGA        | NMJ                | 96   | 1000           | RoHS & Green    | SNAGCU                               | Level-3-260C-168 HR  | 0 to 70      | SU864                   | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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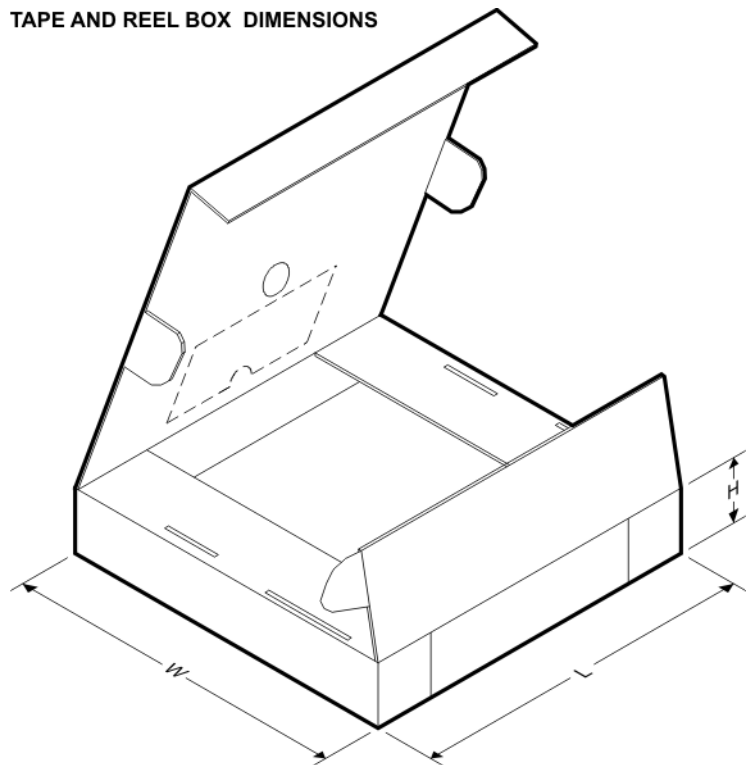
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

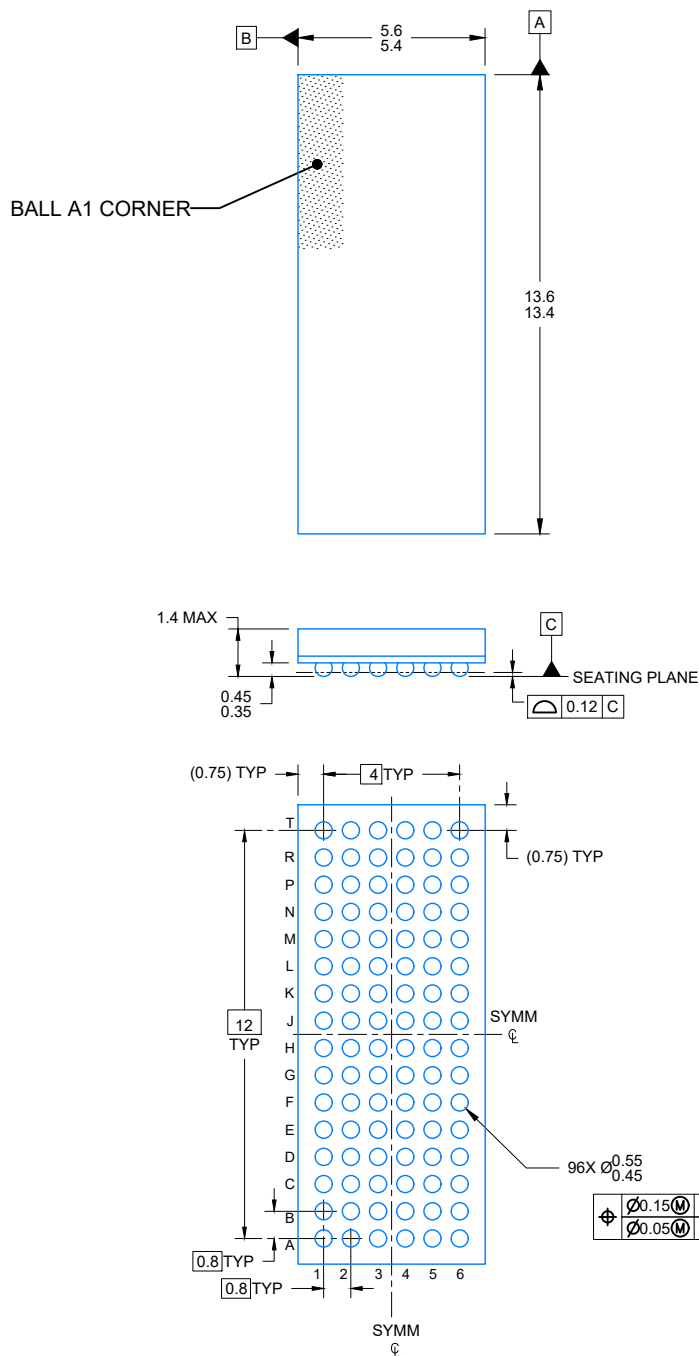
| Device            | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| SN74SSTU32864NMJR | NFBGA        | NMJ             | 96   | 1000 | 330.0              | 24.4               | 5.85    | 13.85   | 1.8     | 8.0     | 24.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device            | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74SSTU32864NMJR | NFBGA        | NMJ             | 96   | 1000 | 336.6       | 336.6      | 41.3        |

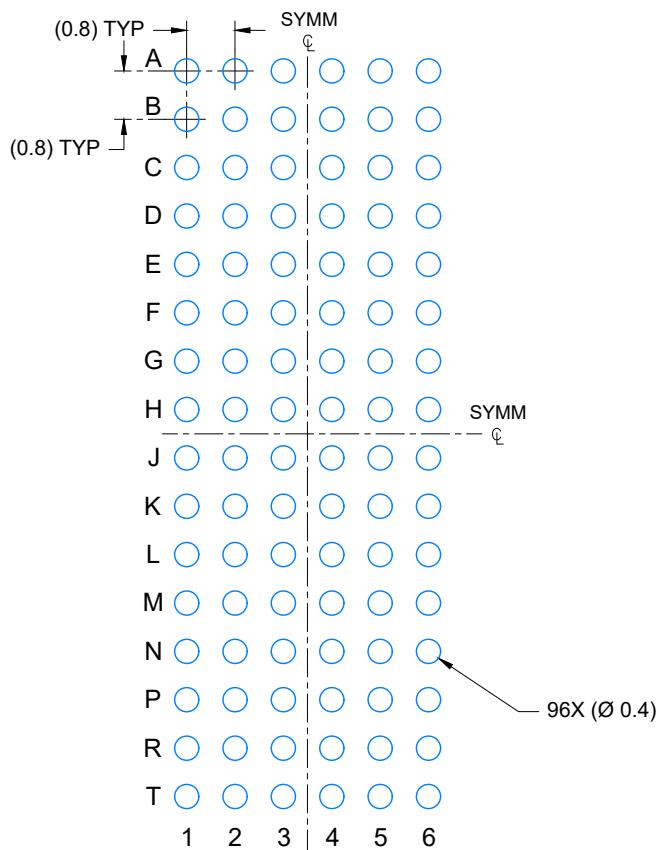


4225132/A 08/2019

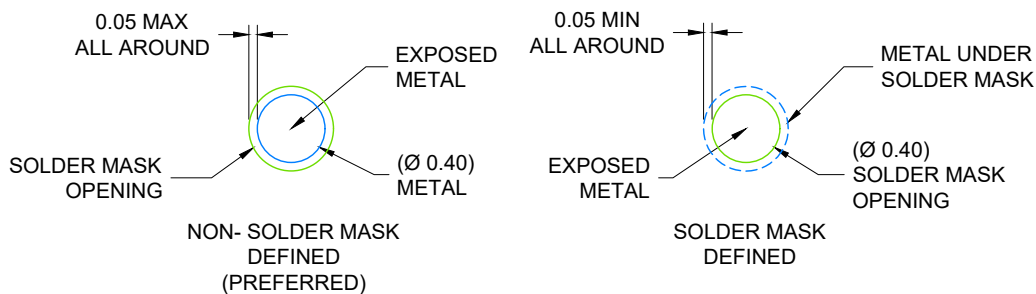
## NOTES:

NanoFree is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.



LAND PATTERN EXAMPLE  
SCALE: 8X



SOLDER MASK DETAILS  
NOT TO SCALE

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NOTES: (continued)

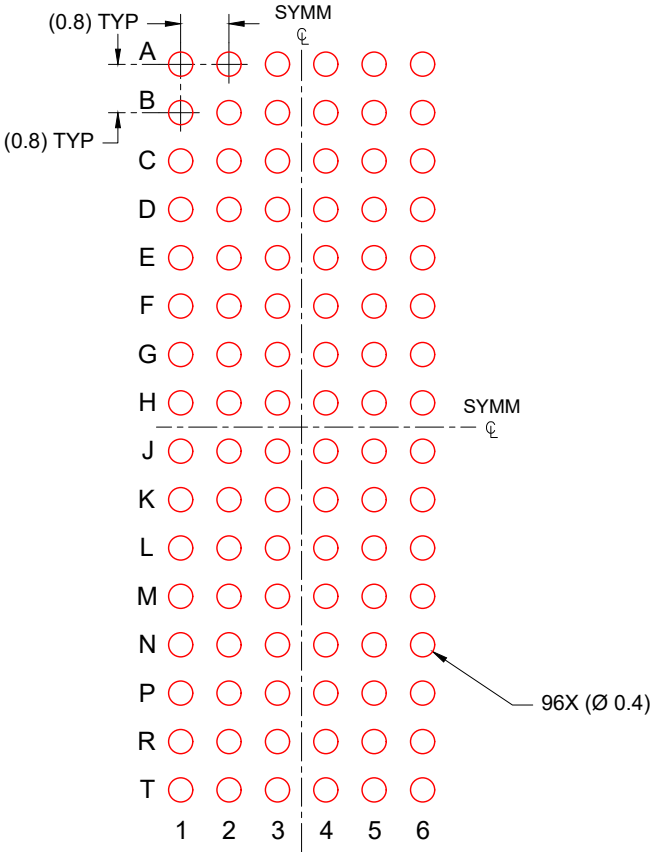
- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. Refer to Texas Instruments Literature number SNVA009 ([www.ti.com/lit/snva009](http://www.ti.com/lit/snva009)).

# EXAMPLE STENCIL DESIGN

NMJ0096A

NFBGA - 1.4 mm max height

PLASTIC BALL GRID ARRAY



SOLDER PASTE EXAMPLE  
BASED ON 0.150 mm THICK STENCIL  
SCALE: 8X

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NOTES: (continued)

- 4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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